

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10754701	SEMICONDUCTOR ENERGY LAB
	<b>Examiner</b>	<b>Art Unit</b>
	DAO H NGUYEN	2818

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
EAST (USPAT; US-PGPUB; USOCR; FPRS; EPO; JPO; IBM_TDB) See attached search history	04/06/2008	DHN

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>